



Sheet 1 of 2

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 120335		APPLICATION NO. 10/501,048	
				APPLICANT(S) Hirotake NOZAKI et al.			
				FILING DATE July 9, 2004		GROUP 2622	
U.S. PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Name			
	1	5,321,663	06/14/1994	Nishi			
	2	6,067,398	05/23/2000	Sato			
	3	7,038,724 B2	05/02/2006	Satoh et al.			
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	5	7,362,961 B2	04/22/2008	Takeshita et al.			
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	8	JP-A-4-268990	09/24/1992	Japan	X		
	9	JP-A-9-182010	07/11/1997	Japan	X		
	10	JP-A-11-27616	01/29/1999	Japan	X		
	11	JP-A-2002-42448	02/08/2002	Japan	X		
	12	JP-A-5-56322	03/05/1993	Japan	X		
	13	JP-A-2001-197412	07/19/2001	Japan	X		
	14	JP-A-2002-16865	01/18/2002	Japan	X		
	15	JP-A-3-191680	08/21/1991	Japan		X	
	16	JP-A-10-248046	09/14/1998	Japan	X	X	
	17	JP-A-2001-298645	10/26/2001	Japan	X	X	
	18	JP-A-7-95517	04/07/1995	Japan	X	X	
OTHER DOCUMENTS							
Examiner Initials	Cite No.	Including name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.					
EXAMINER					DATE CONSIDERED		
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Date: February 25, 2010

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INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Hirotake NOZAKI et al.			
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FOREIGN PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation	
	19	JP-A-2000-295517	10/20/2000	Japan	X	X	
	20	JP-A-10-336572	12/18/1998	Japan	X	X	
	21	JP-A-2001-78061	03/23/2001	Japan	X	X	
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	27	JP-A-2001-245249	09/07/2001	Japan	X	X	
OTHER DOCUMENTS							
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